Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/073,106	YAMAMOTO ET	ΓAL.
Examiner	Art Unit	
Paul D. Kim	3729	

SEARCHED			
Class	Subclass	Date	Examiner
29	831 832 840 841 844 846 851	6/30/2005	PK
156	64 356		
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	DATE	EXMR
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Scott Geyer (438)	2/2/2006	PK
Updated Text Search EAST	2/2/2006	PK
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